

DESCRIPTION

The MXN3060 uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

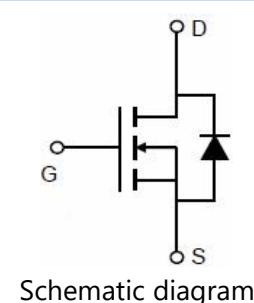
GENERAL FEATURES

- $V_{DS}=30V$, $I_D=60A$
- $R_{DS(ON)}(\text{Typ.})=6.0\text{m}\Omega$ @ $V_{GS}=4.5V$
- $R_{DS(ON)}(\text{Typ.})=5.0\text{m}\Omega$ @ $V_{GS}=10V$
- Low density cell design
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high E_{AS}
- Excellent package for good heat dissipation

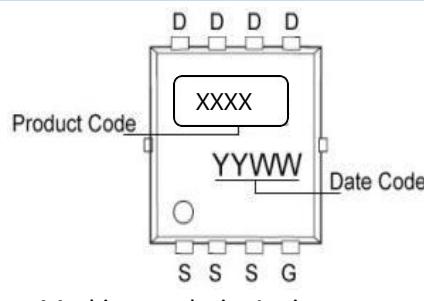
APPLICATION

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply

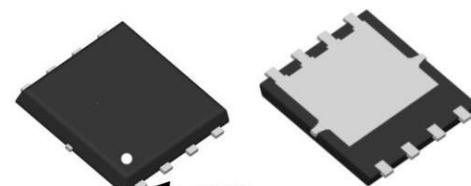
PINOUT



Schematic diagram



Marking and pin Assignment



DFN5X6-8L top&bottom view

ORDERING INFORMATION

Part Number	Storage Temperature	Package	Devices Per Reel
MXN3060	-55°C to 150°C	DFN5X6-8L	5000

ABSOLUTE MAXIMUM RATINGS ($T_c=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	30	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current-Continuous	I_D	60	A
Pulsed Drain Current ^(Note1)	I_{DM}	150	A
Maximum Power Dissipation	P_D	42	W
Derating factor		0.5	W/ $^\circ\text{C}$
Operating Junction and Storage Temperature Range	T_J , T_{STG}	-55 to 150	$^\circ\text{C}$

THERMAL RESISTANCE

Thermal Resistance, Junction-to-Case ^(Note2)	$R_{\theta JC}$	3.0	$^\circ\text{C/W}$
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Note 1. Repetitive Rating: Pulse width limited by maximum junction temperature.

Note 2. Surface Mounted on FR4 Board, $t \leq 10$ sec.


ELECTRICAL CHARACTERISTICS($T_C=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_D=250\mu\text{A}$	30	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$\text{V}_{\text{DS}}=24\text{V}, \text{V}_{\text{GS}}=0\text{V}$	-	-	1	μA
Gate-Body Leakage Current	I_{GSS}	$\text{V}_{\text{GS}}=\pm20\text{V}, \text{V}_{\text{DS}}=0\text{V}$	-	-	±100	nA
On Characteristics ^(Note 3)						
Gate Threshold Voltage	$\text{V}_{\text{GS}(\text{th})}$	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_D=250\mu\text{A}$	1.0	1.4	2.0	V
Drain-Source On-State Resistance	$\text{R}_{\text{DS}(\text{ON})}$	$\text{V}_{\text{GS}}=4.5\text{V}, \text{I}_D=20\text{A}$	-	6.0	9.0	$\text{m}\Omega$
		$\text{V}_{\text{GS}}=10\text{V}, \text{I}_D=20\text{A}$	-	5.0	6.5	$\text{m}\Omega$
Forward Transconductance	g_{FS}	$\text{V}_{\text{DS}}=5\text{V}, \text{I}_D=20\text{A}$	-	57	-	S
Dynamic Characteristics ^(Note 4)						
Input Capacitance	C_{iss}	$\text{V}_{\text{DS}}=15\text{V}, \text{V}_{\text{GS}}=0\text{V}, \text{F}=1.0\text{MHz}$	-	1950	-	pF
Output Capacitance	C_{oss}		-	310	-	pF
Reverse Transfer Capacitance	C_{rss}		-	240	-	pF

Switching Characteristics^(Note 4)

Turn-on Delay Time	$t_{\text{d}(\text{on})}$	$\text{V}_{\text{DD}}=15\text{V}, \text{R}_{\text{L}}=15\Omega, \text{V}_{\text{GS}}=10\text{V}, \text{R}_{\text{G}}=2.5\Omega$	-	8.1	-	nS
Turn-on Rise Time	t_{r}		-	8.6	-	nS
Turn-Off Delay Time	$t_{\text{d}(\text{off})}$		-	30	-	nS
Turn-Off Fall Time	t_{f}		-	9	-	nS
Total Gate Charge	Q_{g}	$\text{V}_{\text{DS}}=15\text{V}, \text{I}_D=20\text{A}, \text{V}_{\text{GS}}=10\text{V}$	-	37	-	nC
Gate-Source Charge	Q_{gs}		-	4.8	-	nC
Gate-Drain Charge	Q_{gd}		-	11	-	nC

Drain-Source Diode Characteristics

Diode Forward Voltage ^(Note 3)	V_{SD}	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_S=20\text{A}$	-	-	1.2	V
Diode Forward Current ^(Note 2)	I_S		-	-	60	A
Reverse Recovery Time	t_{rr}	$\text{T}_J = 25^\circ\text{C}, \text{I}_F = 20\text{A}$ $\text{di}/\text{dt} = 100\text{A}/\mu\text{s}$ ^(Note 3)	-	26	-	nS
Reverse Recovery Charge	Q_{rr}		-	34	-	nC
Forward Turn-On Time	t_{on}	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

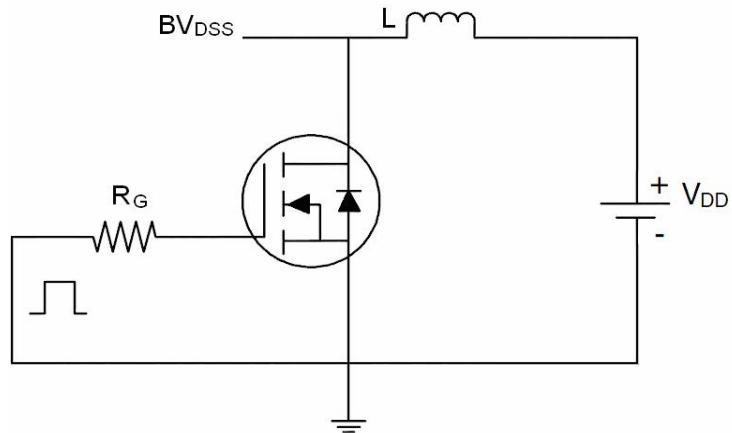
Note 2. Surface Mounted on FR4 Board, $t \leq 10$ sec.

Note 3. Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$.

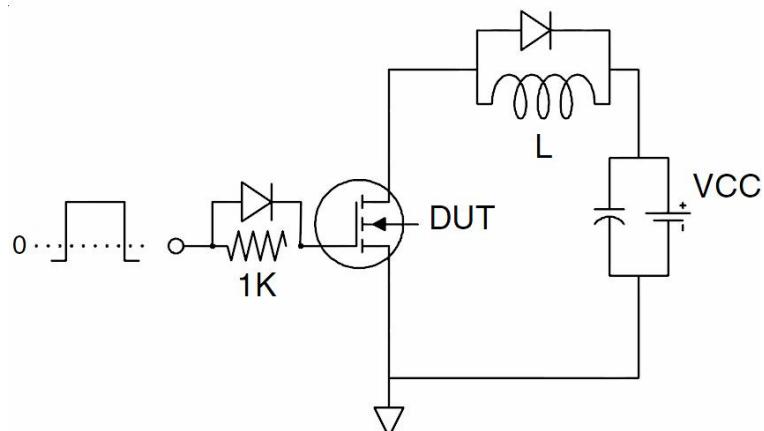
Note 4. Guaranteed by design, not subject to product.

TEST CIRCUIT

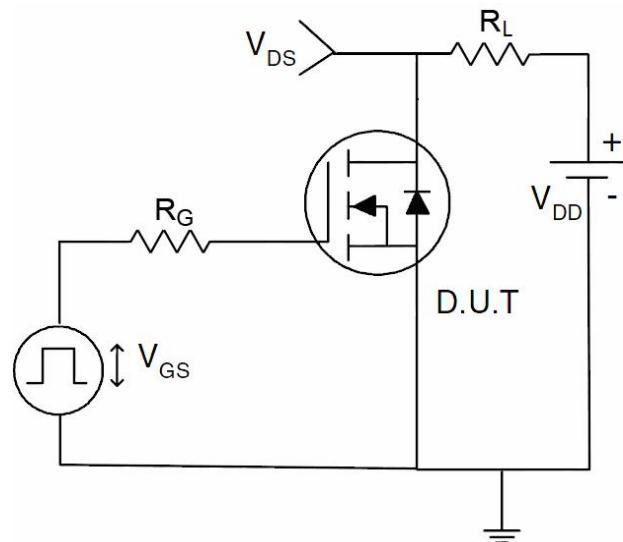
1. E_{AS} Test Circuit

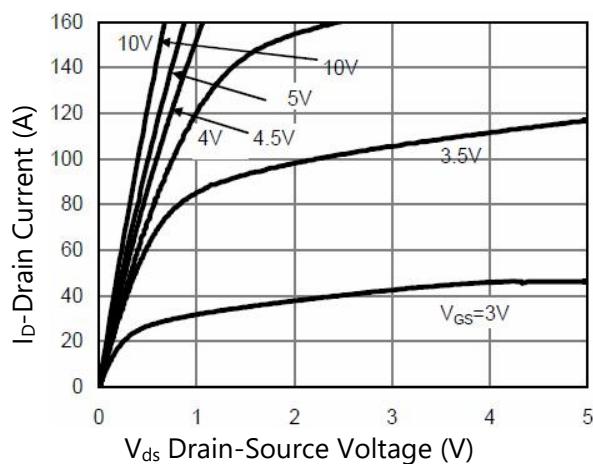
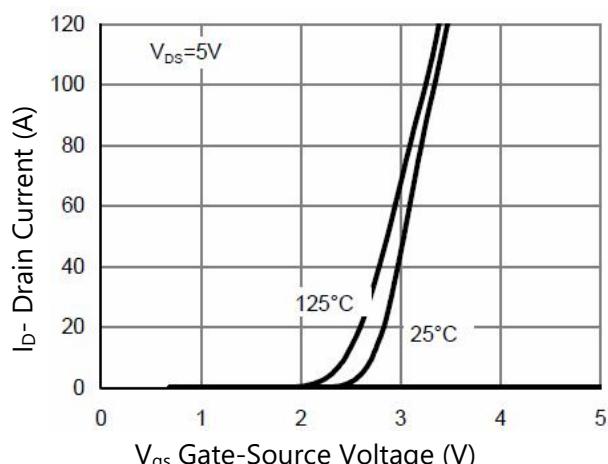
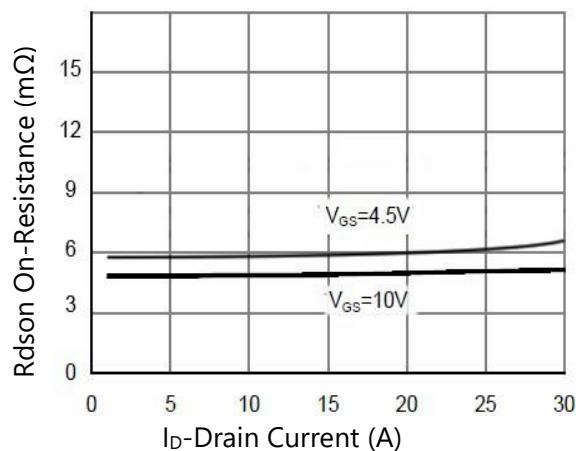
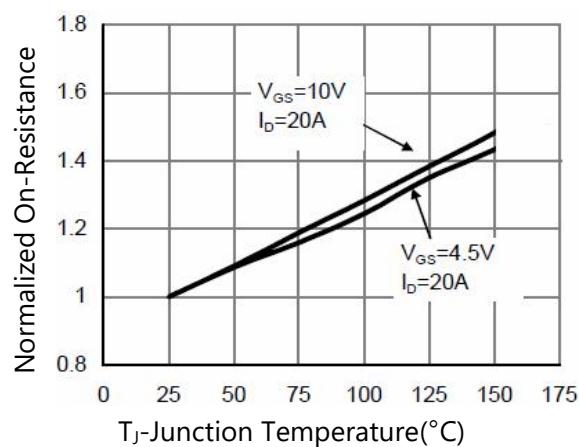
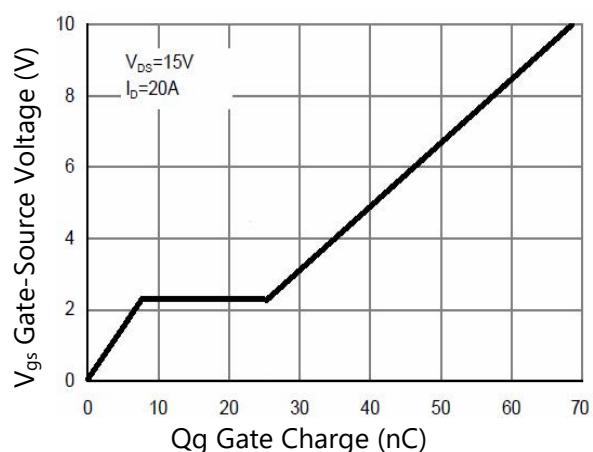
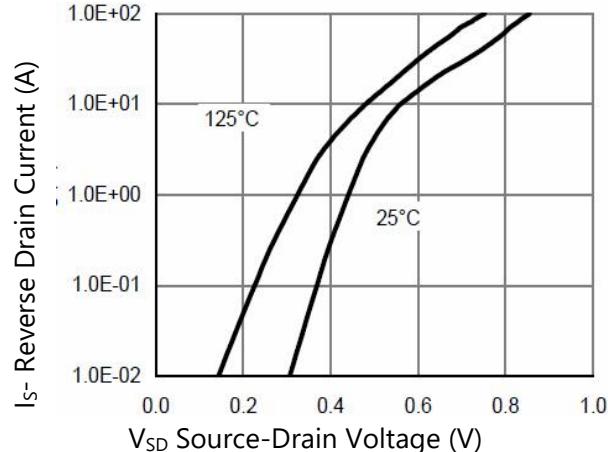


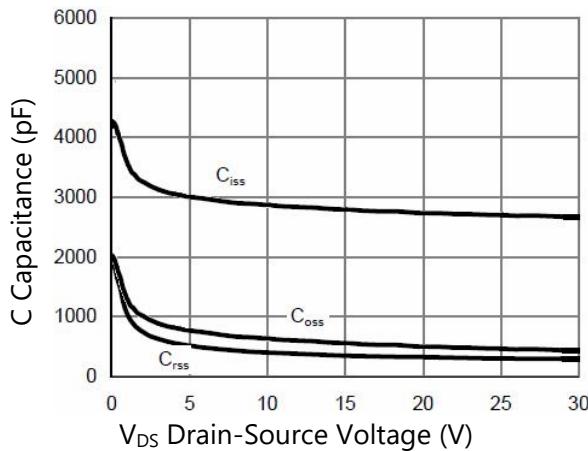
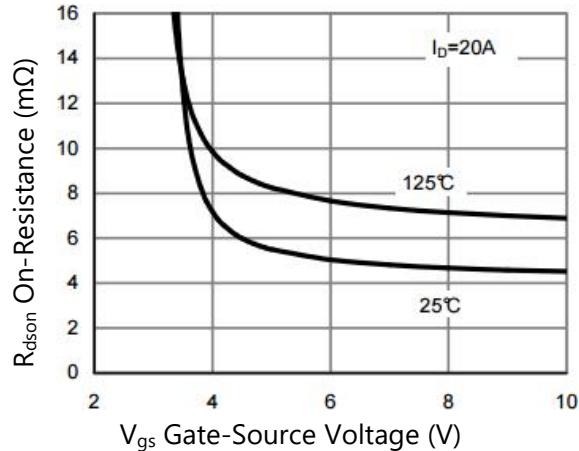
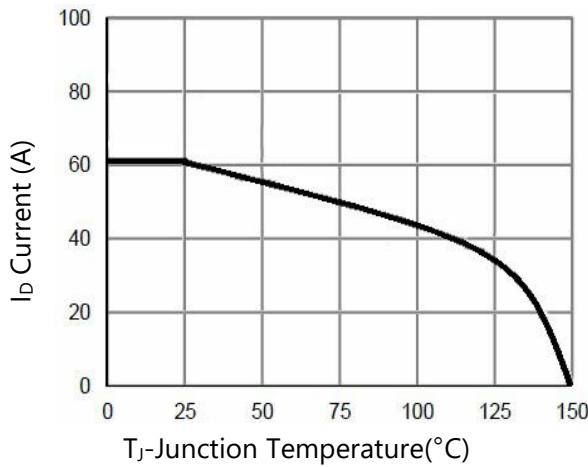
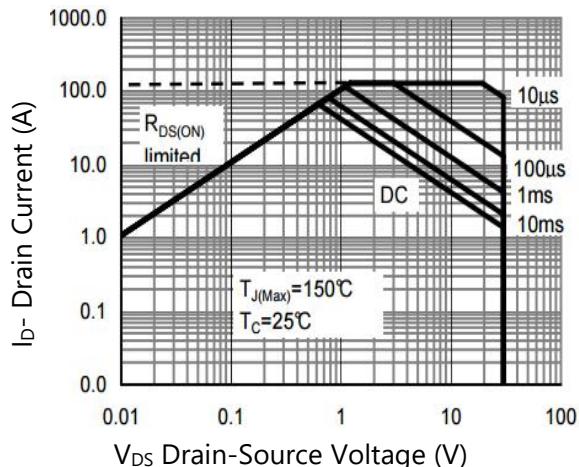
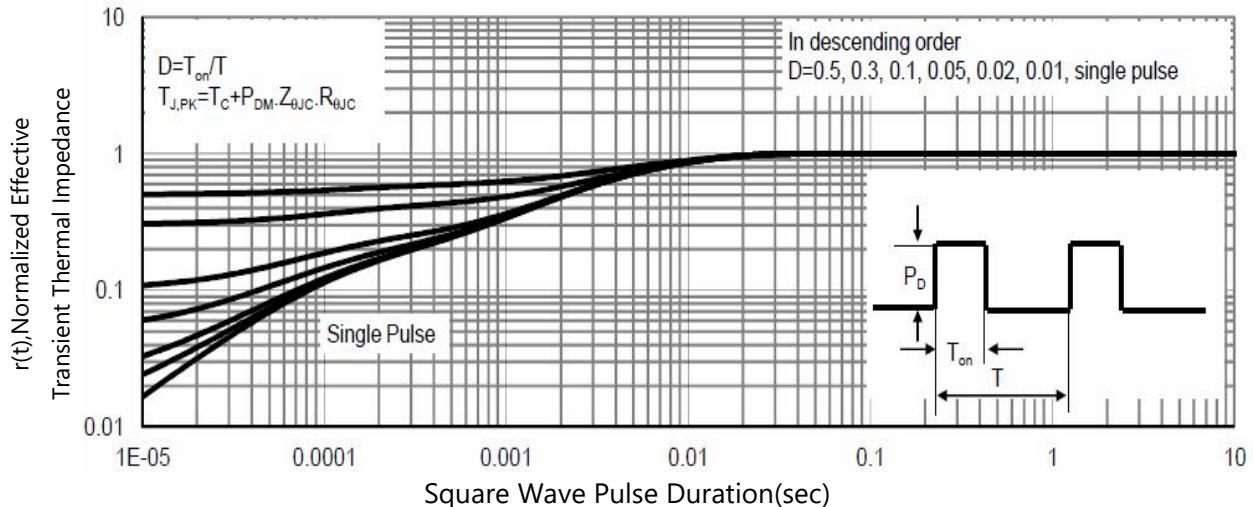
2. Gate Charge Test Circuit



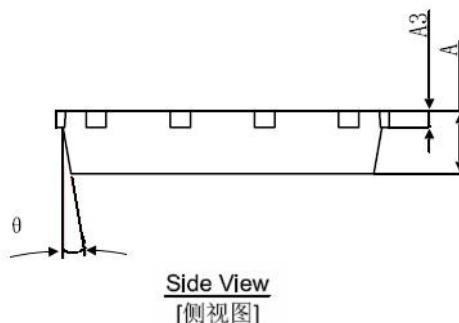
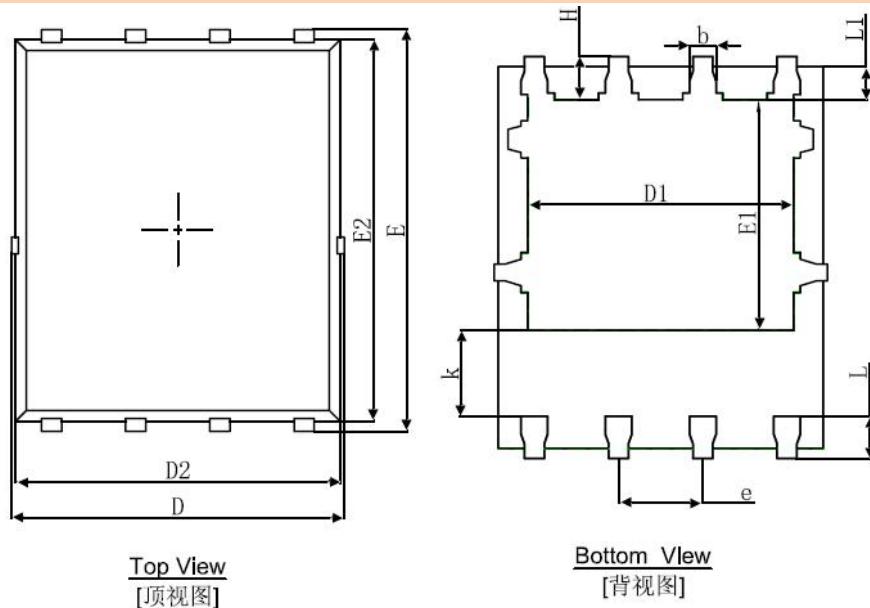
3. Switch Time Test Circuit




TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS
Figure 1. Output Characteristics

Figure 2. Transfer Characteristics

Figure 3. R_{dson} vs Drain Current

Figure 4. R_{dson} vs Junction Temperature

Figure 5. Gate Charge

Figure 6. Source- Drain Diode Forward



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS
Figure 7. Capacitance vs V_{DS}

Figure 8. R_{dson} vs Gate-Source Voltage

Figure 9. Current- Junction Temperature

Figure 10. Safe Operation Area

Figure 11. Normalized Maximum Transient Thermal Impedance


PACKAGE INFORMATION

DFN5X6-8L


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.000	0.035	0.039
A3	0.254REF.		0.010REF.	
D	4.944	5.096	0.195	0.201
E	5.974	6.126	0.235	0.241
D1	3.910	4.110	0.154	0.162
E1	3.375	3.575	0.133	0.141
D2	4.824	4.976	0.190	0.196
E2	5.674	5.826	0.223	0.229
k	1.190	1.390	0.047	0.055
b	0.350	0.450	0.014	0.018
e	1.270TYP.		0.050TYP.	
L	0.559	0.711	0.022	0.028
L1	0.424	0.576	0.017	0.023
H	0.574	0.726	0.023	0.029
θ	8°	12°	8°	12°